

Circuits and MOS Small-Signal Models

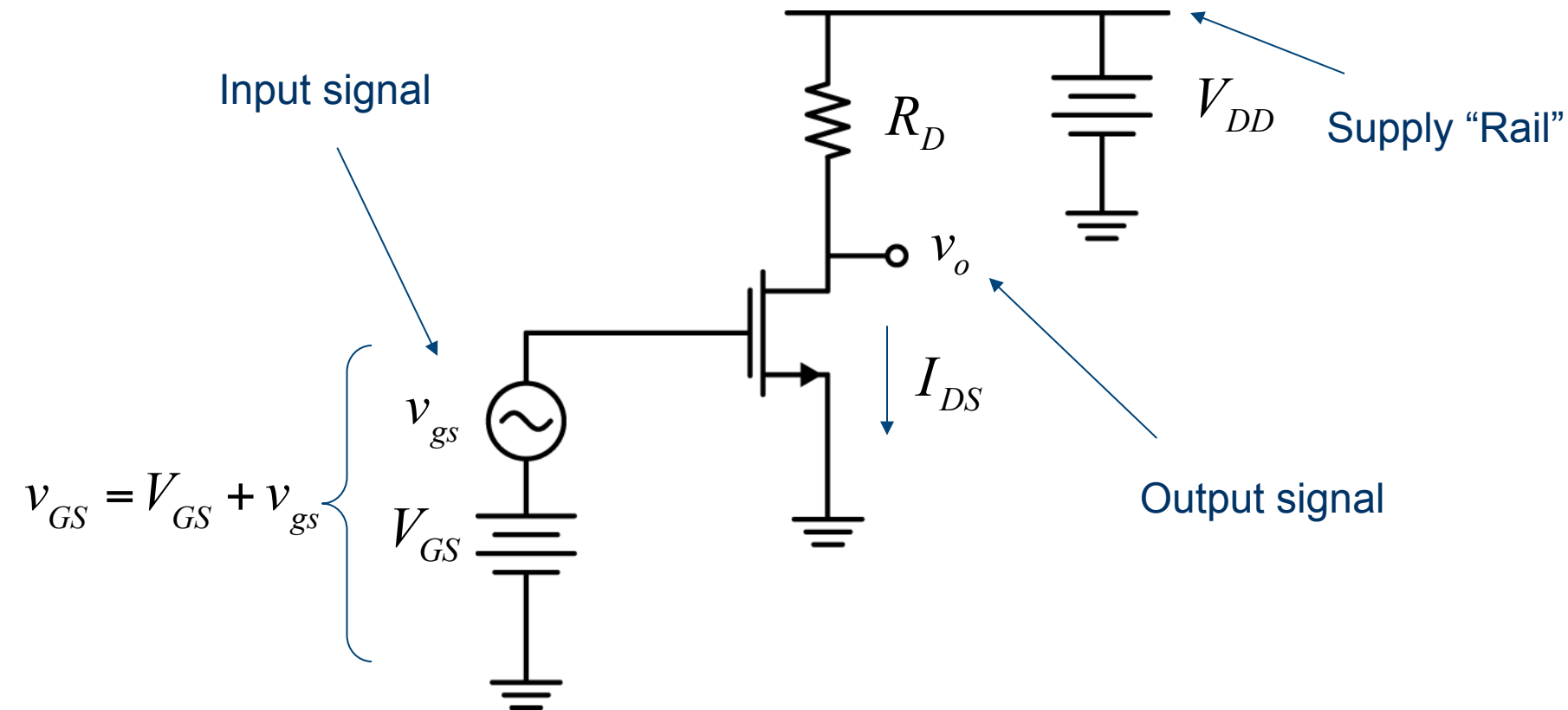
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Announcements

- HW 7 is last HW before Midterm
- Next HW will be posted before Spring Break and due Friday after Spring Break (2 weeks to complete)
- Next week: Midterm Review (Tuesday), Midterm (Thursday)
- Syllabus after Spring Break will be updated

A Simple Circuit: An MOS Amplifier



Selecting the Output Bias Point

- The bias voltage V_{GS} is selected so that the output is mid-rail (between V_{DD} and ground)
- For gain, the transistor is biased in saturation
- Constraint on the DC drain current:

$$I_R = \frac{V_{DD} - V_o}{R_D} = \frac{V_{DD} - V_{DS}}{R_D}$$

- All the resistor current flows into transistor:

$$I_R = I_{DS,sat}$$

- Must ensure that this gives a self-consistent solution (transistor is biased in saturation)

$$V_{DS} > V_{GS} - V_T$$

Finding the Input Bias Voltage

- Ignoring the output impedance

$$I_{DS,sat} = \frac{W}{L} \mu_n C_{ox} \frac{1}{2} (V_{GS} - V_{Tn})^2$$

- Typical numbers: $W = 40 \mu\text{m}$, $L = 2 \mu\text{m}$, $R_D = 25\text{k}\Omega$, $\mu_n C_{ox} = 100 \mu\text{A}/\text{V}^2$, $V_{Tn} = 1 \text{ V}$, $V_{DD} = 5 \text{ V}$

$$I_{R_D} = \frac{V_{DD}}{2R_D} = I_{DS,sat} = \frac{W}{L} \mu_n C_{ox} \frac{1}{2} (V_{GS} - V_{Tn})^2$$

$$\frac{5\text{V}}{50\text{k}\Omega} = 100\mu\text{A} = 20 \cdot 100 \frac{\mu\text{A}}{\text{V}^2} \cdot \frac{1}{2} (V_{GS} - 1)^2$$

$$.1 = (V_{GS} - 1\text{V})^2 \quad V_{GS} = 1.32\text{V} \quad V_{GS} - V_T = .32\text{V} < V_{DS} = 2.5\text{V} \checkmark$$

Applying the Small-Signal Voltage

Approach I. Just use v_{GS} in the equation for the total drain current i_D and find v_o

$$v_{GS} = V_{GS} + v_{gs}$$

$$v_s = \hat{v}_s \cos \omega t$$

$$v_o = V_{DD} - R_D i_{DS} = V_{DD} - R_D \mu_n C_{ox} \frac{W}{L} \frac{1}{2} (V_{GS} + v_{gs} - V_T)^2$$

Note: Neglecting charge storage effects. Ignoring device output impedance.

Solving for the Output Voltage v_O

$$v_O = V_{DD} - R_D i_{DS} = V_{DD} - R_D \mu_n C_{ox} \frac{W}{L} \frac{1}{2} (V_{GS} + v_{gs} - V_T)^2$$

$$v_O = V_{DD} - R_D i_{DS} = V_{DD} - \underbrace{R_D \mu_n C_{ox} \frac{W}{L} \frac{1}{2} (V_{GS} - V_T)^2}_{I_{DS}} \left(1 + \frac{v_{gs}}{V_{GS} - V_T} \right)^2$$

$$v_O = V_{DD} - \underbrace{R_D I_{DS}}_{\frac{V_{DD}}{2}} \left(1 + \frac{v_{gs}}{V_{GS} - V_T} \right)^2$$

Small-Signal Case

- Linearize the output voltage for the s.s. case
- Expand $(1 + x)^2 = 1 + 2x + x^2 \dots$ last term can be dropped when $x \ll 1$

$$\left(1 + \frac{2v_{gs}}{V_{GS} - V_T}\right)^2 = 1 + \frac{2v_{gs}}{V_{GS} - V_T} + \left(\frac{v_{gs}}{V_{GS} - V_T}\right)^2$$

Neglect

$$v_O \approx V_{DD} - R_D I_{DS} \left(1 + \frac{2v_{gs}}{V_{GS} - V_T}\right)$$

Linearized Output Voltage

For this case, the total output voltage is:

$$v_O \approx V_{DD} - I_D R_{DS} \left(1 + \frac{2v_{gs}}{V_{GS} - V_T} \right)$$

$$v_O \approx \underbrace{(V_{DD} - I_D R_{DS})}_{\text{"DC"}} - \frac{2I_D R_{DS} v_{gs}}{V_{GS} - V_T} = \frac{V_{DD}}{2} - \frac{V_{DD} v_{gs}}{V_{GS} - V_T}$$

"DC"

Small-signal output

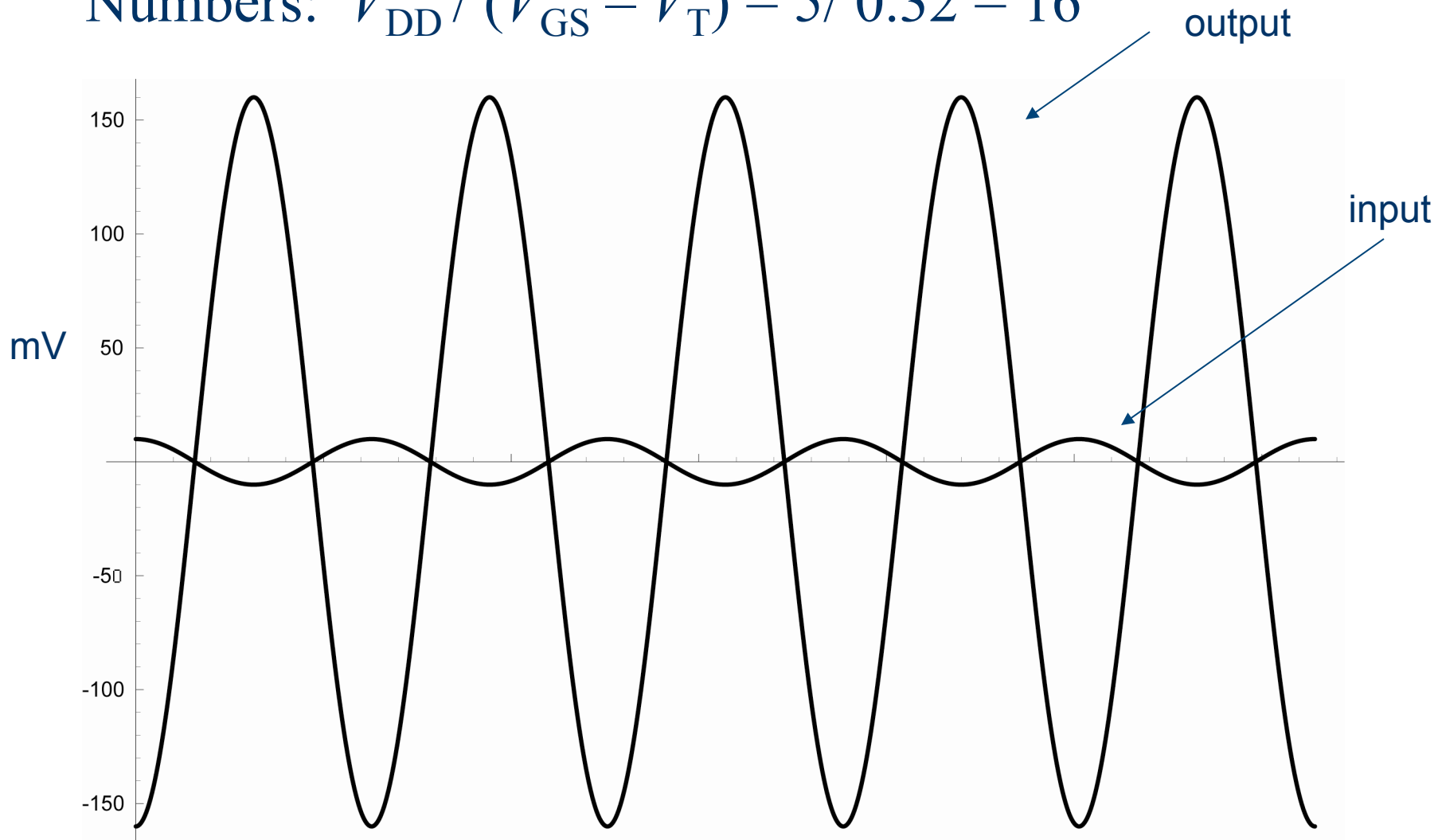
The small-signal output voltage:

$$v_o \approx - \frac{2I_D R_{DS} v_{gs}}{V_{GS} - V_T} = - \frac{V_{DD} v_{gs}}{V_{GS} - V_T} A_v v_{gs}$$

Voltage gain

Plot of Output Waveform (Gain!)

Numbers: $V_{DD} / (V_{GS} - V_T) = 5 / 0.32 = 16$



There is a Better Way!

- *What's missing: didn't include device output impedance or charge storage effects (must solve non-linear differential equations...)*
- *Approach II: Solve problem in two steps.*
 - 1) DC voltages and currents (ignore small signals sources): set bias point of the MOSFET ... we had to do this to pick V_{GS} already
 - 2) Substitute the small-signal model of the MOSFET and the small-signal models of the other circuit elements ...
- This constitutes small-signal analysis

Total Small Signal Current

$$i_{DS}(t) = I_{DS} + i_{ds}$$

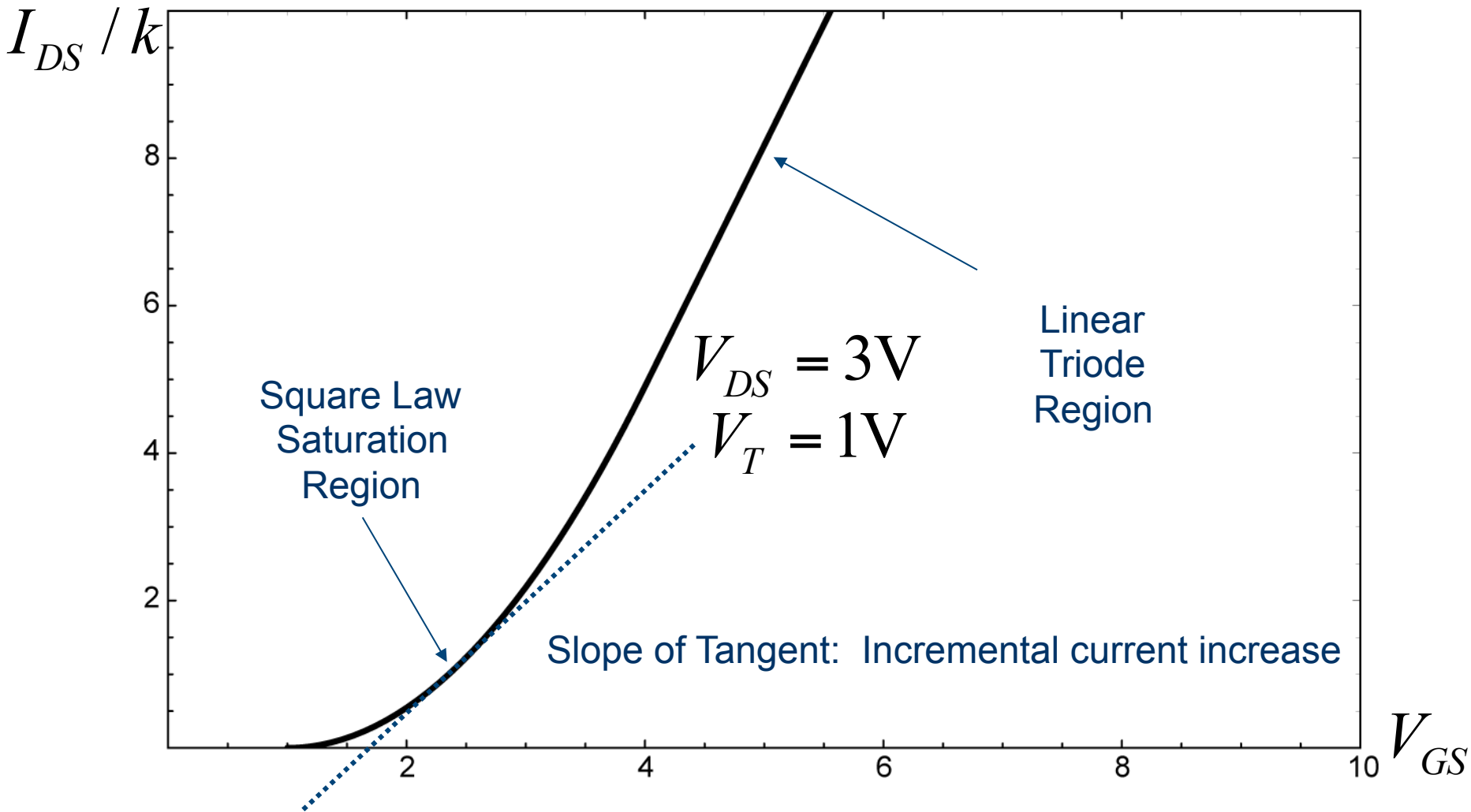
$$i_{ds} = \frac{\partial i_{DS}}{\partial v_{gs}} v_{gs} + \frac{\partial i_{DS}}{\partial v_{ds}} v_{ds}$$

$$i_{ds} = g_m v_{gs} + \frac{1}{r_o} v_{ds}$$

Transconductance

Conductance

Changing One Variable at a Time



Assumption: $V_{DS} > V_{DS,SAT} = V_{GS} - V_{Tn}$ (square law)

The Transconductance g_m

Defined as the change in drain current due to a change in the *gate-source* voltage, with *everything else constant*

$$I_{DS,sat} = \frac{W}{L} \frac{\mu C_{ox}}{2} (V_{GS} - V_T)^2 (1 + \lambda V_{DS})$$

$$g_m = \left. \frac{\Delta i_D}{\Delta v_{GS}} \right|_{V_{GS}, V_{DS}} = \left. \frac{\partial i_D}{\partial v_{GS}} \right|_{V_{GS}, V_{DS}} = \mu C_{ox} \frac{W}{L} (V_{GS} - V_T) (1 + \lambda V_{DS}) \approx 0$$

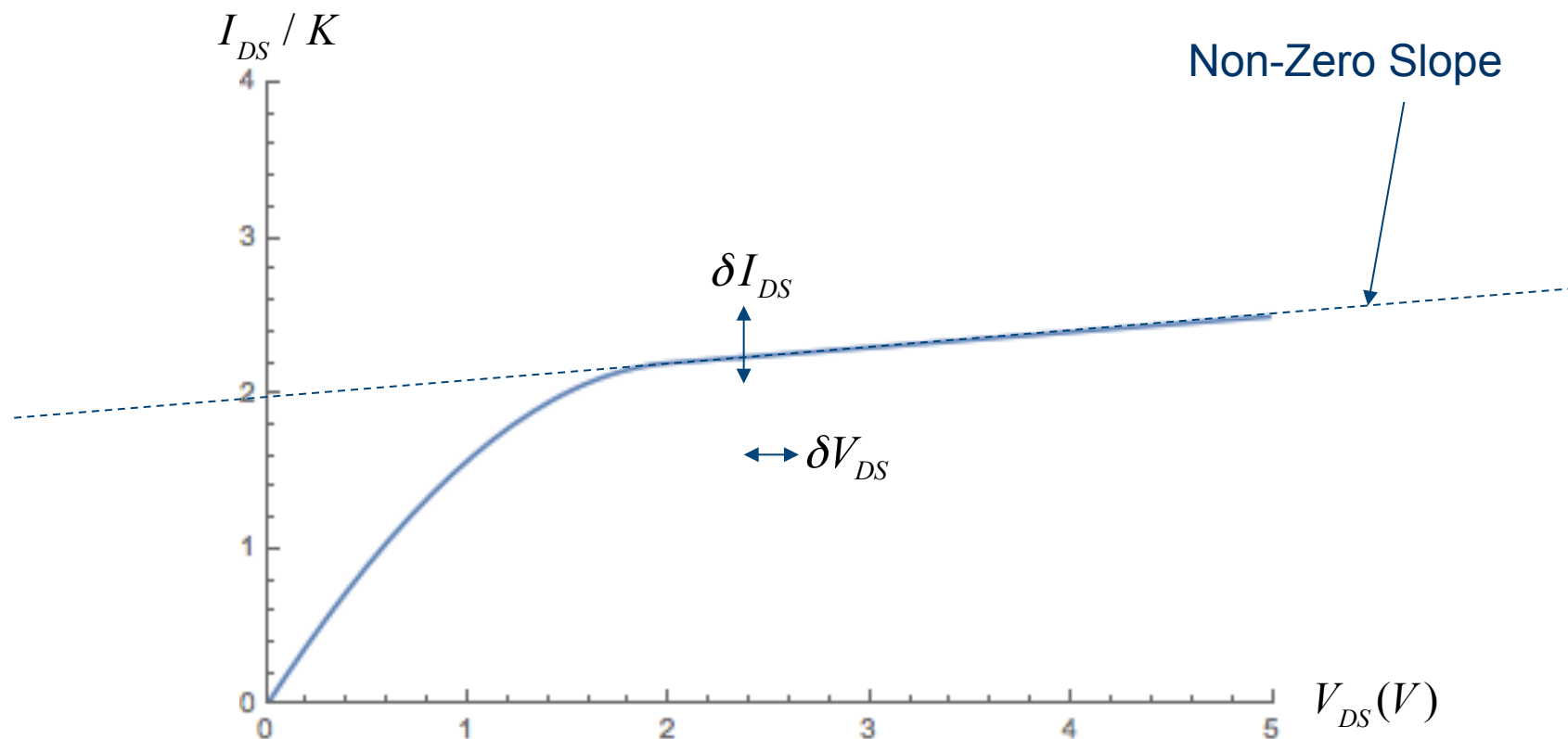
$$g_m = \mu C_{ox} \frac{W}{L} (V_{GS} - V_T) \quad \leftarrow \text{Gate Bias}$$

$$g_m = \mu C_{ox} \frac{W}{L} \sqrt{\frac{2I_{DS}}{\frac{W}{L} \mu C_{ox}}} = \sqrt{2 \mu C_{ox} \frac{W}{L} I_{DS}} \quad \leftarrow \text{Drain Current Bias}$$

$$g_m = \frac{2I_{DS}}{(V_{GS} - V_T)} \quad \leftarrow \text{Drain Current Bias and Gate Bias}$$

Output Resistance r_o

Defined as the inverse of the change in drain current due to a change in the *drain-source* voltage, with *everything else constant*



Evaluating r_o

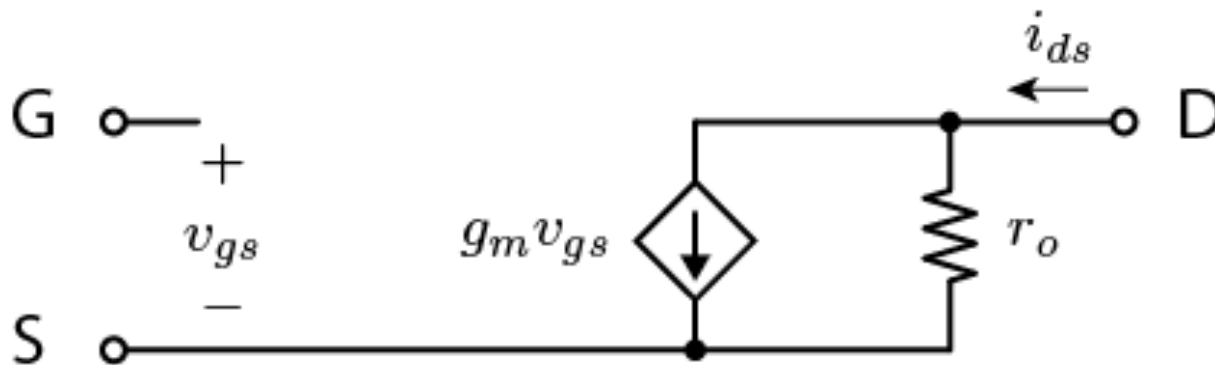
$$i_D = \frac{W}{L} \frac{\mu C_{ox}}{2} (V_{GS} - V_T)^2 (1 + \lambda V_{DS})$$

$$r_o = \left(\frac{\partial i_D}{\partial v_{DS}} \bigg|_{V_{GS}, V_{DS}} \right)^{-1}$$

$$r_o = \frac{1}{\frac{W}{L} \frac{\mu C_{ox}}{2} (V_{GS} - V_T)^2 \lambda}$$

$$r_o \approx \frac{1}{\lambda I_{DS}}$$

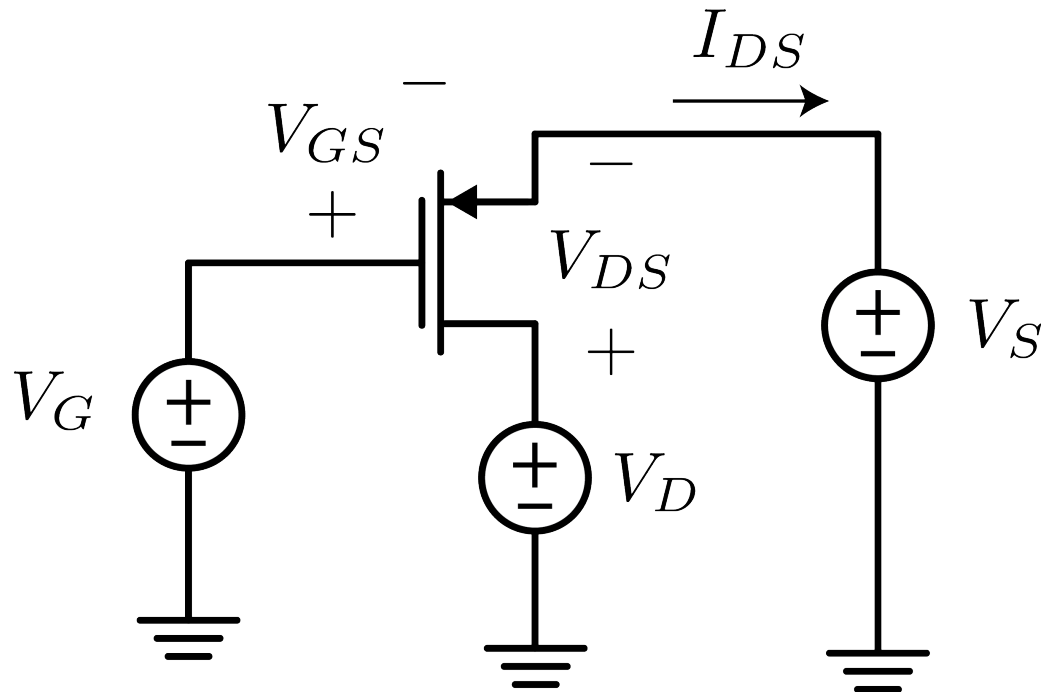
Three-Terminal Small-Signal Model



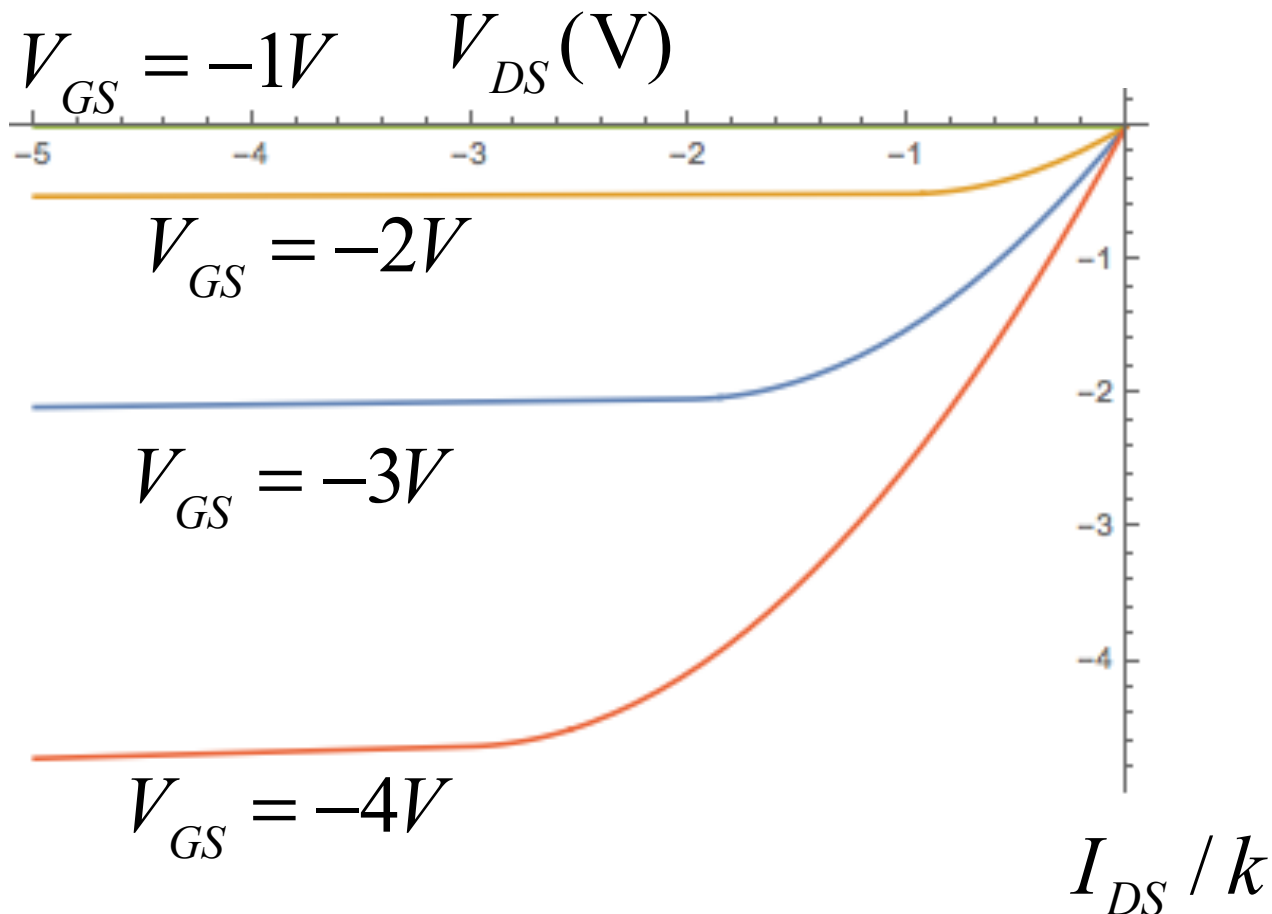
$$i_{ds} = g_m v_{gs} + \frac{1}{r_o} v_{ds}$$

P-Channel MOSFET

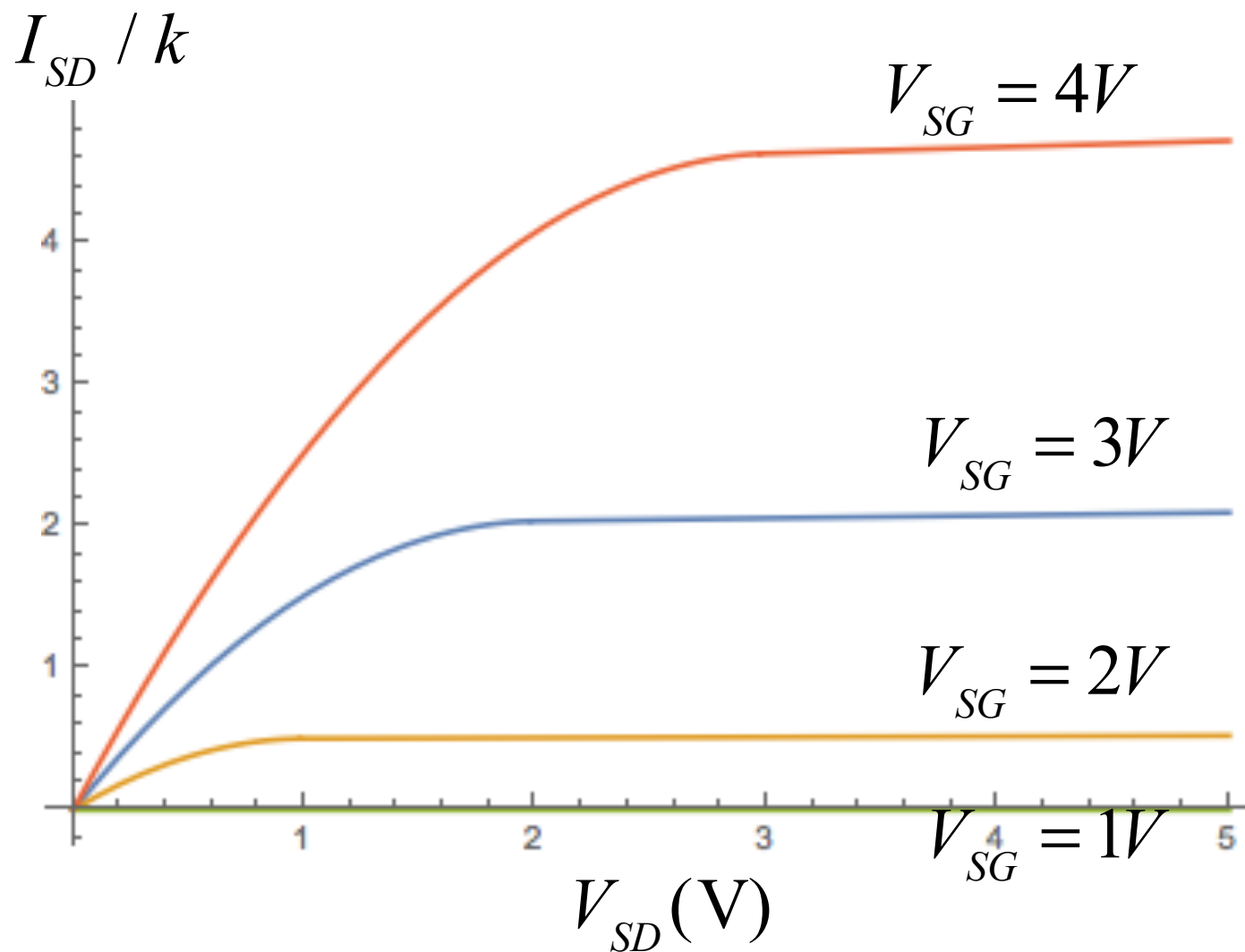
Everything is flipped around compared to an NMOS.
Currents are negative of NMOS.



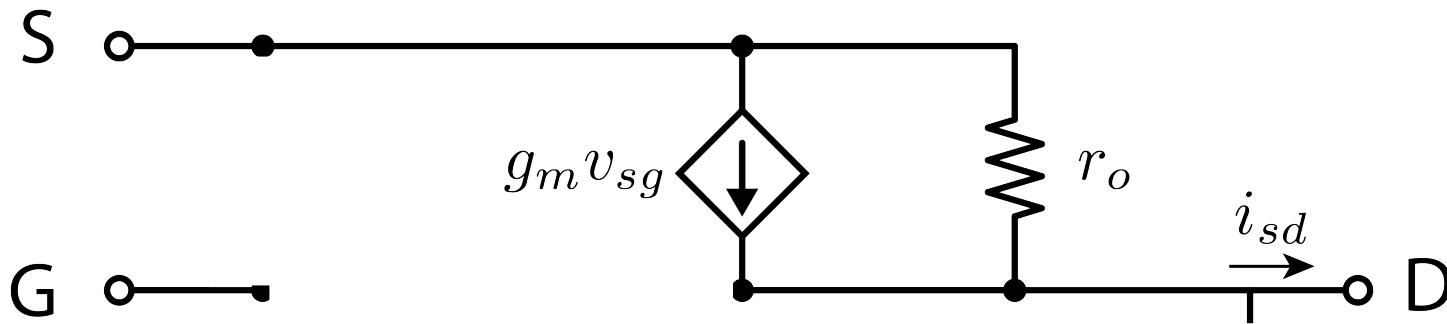
Square-Law PMOS Characteristics



Right Side Up!



Small-Signal PMOS Model



What we're ignoring for now...

- The fourth terminal of the MOSFET is the body of the transistor... it can act like a second gate, or “back gate”
- The junctions of the transistor form pn-junction diodes with body, this introduces parasitic capacitance
- Modern transistors are very short channel lengths, and there are many “short channel” effects that we're ignoring, most prominently velocity saturation
- Subthreshold conduction
- Capacitance!